

IEC QUALITY ASSESSMENT SYSTEM (IECQ)

For rules and details of the IECQ visit www.iecq.org

IECQ Certificate of Approval Independent Testing Laboratory

IECQ Certificate No.: IECQ-L DEKRA 16.0002-04 Issue No.: 1 Status: Draft

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Integrated Service Technology, Inc.

1F., No. 38, Taiyuan St., Zhubei City, Hsinchu County 302082 Taiwan

The organization, facilities and procedures have been assessed by the IECQ Certification Body in accordance with IECQ 03-1 and IECQ 03-6 for issuance of this certificate and found to be in conformity with the applicable requirements of the IECQ Independent Testing Laboratory Assessment Program Requirements Scheme and in respect of ISO/IEC 17025:2017 for the testing of component product under the IECQ.

Scope:

Environmental and Reliability Testing of Electronic Components, Assemblies, and Related Materials

See attached Schedule of Scope

-- Attached Schedule: IECQ-L DEKRA 16.0002-04-S.pdf --

Approved by Certification Body (CB): DEKRA Certification B.V.

Meander 1051 Arnhem

Netherlands

Authorized person:

Ted Gaertner







The validity of this certificate is maintained through on-going surveillance audits by the IECQ CB issuing this certificate.

This Certificate of Conformity may be suspended or withdrawn in accordance with the Rules of Procedure of the IECQ System and its Schemes.

This certificate and any schedule(s) may only be reproduced in full.

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IEC QUALITY ASSESSMENT SYSTEM (IECQ)

covering Electronic Components,
Assemblies, Related Materials and Processes

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Schedule of Scope to Certificate of Approval

Independent Testing Laboratory

IECQ Certificate No.: IECQ-L DEKRA 16.0002-04

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Schedule Number: IECQ-L DEKRA 16.0002-04-S Rev No.: 1 Revision Date: 2025/07/20 Page 1 of 1

Environmental and Reliability Testing of Electronic Components, Assemblies, and Related Materials

Description test	Standard
TEM analysis	A00-530-30057, A00-530-30197
DUAL BEAM FIB analysis	A00-530-30130



